FORM PTO-1449/A and B (Modified)					APPLICATION NO.: 10/068,307 ATTY. DOCKET NO.: \$01022/8084		
OE.				CLOSURE	FILING DATE: February 6, 2002 APPLICANT: Steven Firth and William Bryan Barnes		
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Examiner's Initials#	Cite	U.S. Patent Doc	cument		Date of Publication or of issu	
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FOREIGN PATENT DOCUMENTS

Examiner's Initials#	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited	Date of Publication of	Translatio
		Office/ Country	Number	Kind Code	Document (not necessary)	Cited Document MM-DD-YY	(Y/N)
C.		EP	0 646 867	Α		04/05/95	
Op		EP	0 805 460	Α		11/05/97	
							
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OTHER ART — NON PATENT LITERATURE DOCUMENTS

Examiner's	Cite	Include name of the author (in CAPITAL LETTERS) title of the article (when appropriate), title of the	Translation
Initials#	No	item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-issue number(s), publisher, city and/or country where published.	(Y/N)
Cp		European Search Report from European application No. 01301092, filed February 7, 2001	
Ch		Array Built-In Self-Test with Diagnostic Logic; IBM Technical Disclosure Bulletin, US, IBM Corp. New York; vol. 34, no. 1, June 1, 1991; pages 59-61, XP000210114	
Ch		Semiconductor Manufacturing Process Monitoring Using Built-In Self-Test for Embedded Memories; International Test Conference, New York, NY, IEEE, vol., Conf. 29, October 19, 1998, pages 872-881, XP000822431	

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#EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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